

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
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		Examiner	Art Unit	
		Paul Dinh	2825	Page 1 of 1

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	B	US-2004/0257571 a1	12-2004	Mieher et al.	356/401
	C	US-6,204,912 b1	03-2001	Tsuchiya et al.	355/53
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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